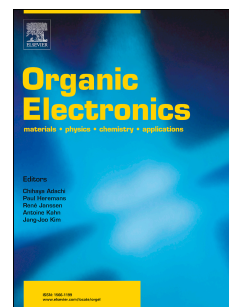


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Degradation mechanism study and electron scattering device structure for long lifetime in blue phosphorescent organic light-emitting diodes

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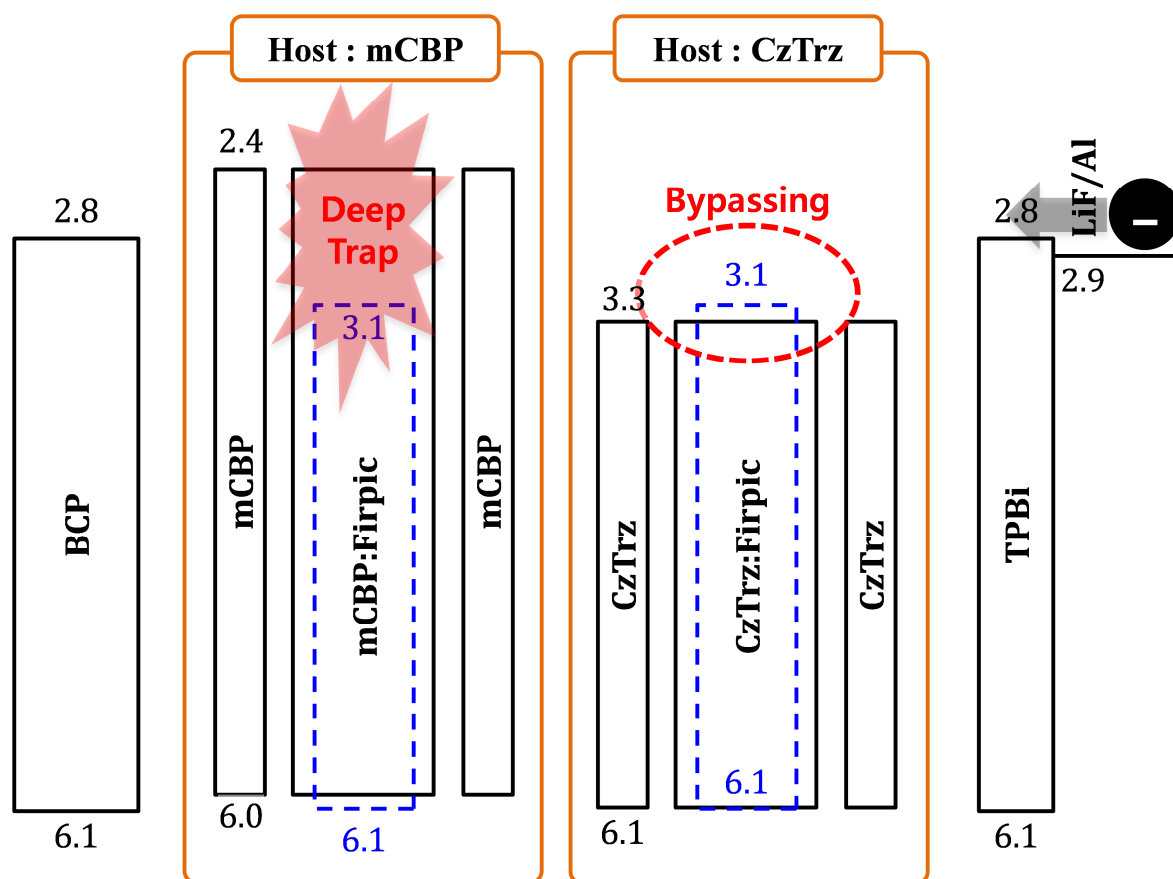
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